

200V N-Channel Enhancement Mode MOSFET

General Features

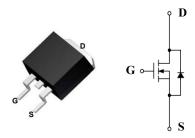
- > Reliable and Rugged
- ➤ Lead Free and Green Devices Available
- ➤ RoHS Compliant
- > Halogen-free available
- ➤ Moisture Sensitivity Level MSL1

Applications

- > Synchronous Rectification
- > Power Management in Inverter Systems
- DC/DC Converter

BV _{DSX}	R _{DS(ON)} (Max.)	I_D			
200V	11m Ω	102A			

TO-263-2



Ordering Information

Part Number	Package	Marking	Remark
FTB200N11	TO-263-2	200N11	Halogen Free

Absolute Maximum Ratings

TA =25°C unless otherwise specified

	8					
Symbol	Parameter	FTB200N11	Unit			
V_{DSS}	Drain-to-Source Voltage	200	V			
V_{GSS}	Gate-to-Source Voltage	±20	V			
I_S	Diode Continuous Forward Current	T _C =25°C	51			
I_D	Continuous Drain Current	T _C =25°C	102	A		
$I_{DM}^{[1]}$	Pulsed Drain Current	T _C =25°C	306			
T_J	Maximum Junction Temperature		150	°C		
T_{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$			



Electrical Characteristics

Static Characteristics

TA =25 $^{\circ}$ C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions
BV _{DSX}	Drain-to-Source Breakdown Voltage	200	-	-	V	V _{GS} =0V, I _{DS} =250 μA
T	Zone Cata Walters Durin Comment	-	ı	1	μΑ	V _{DS} =160V,
I_{DSS}	Zero Gate Voltage Drain Current	-	-	30		$V_{GS}=0V$ $T_{J}=85^{\circ}C$
V _{GS(th)}	Gate Threshold Voltage	2	3	4	V	$V_{DS}=V_{GS},I_{DS}=250~\mu A$
I_{GSS}	Gate Leakage Current	-	-	±100	nA	$V_{GS}=\pm20V, V_{DS}=0V$
R _{DS(ON)} [2]	Drain-to-Source On-state Resistance	-	10	11	mΩ	V _{GS} =10V, I _{DS} =50A

Diode Characteristics

TA =25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$V_{SD}^{[2]}$	Diode Forward Voltage	-	0.8	-	V	I_{SD} =25A, V_{GS} =0V

Dynamic Characteristics [3]

TA =25°C unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
R_{G}	Gate Resistance	-	2	-	Ω	$V_{GS}=0V, V_{DS}=0V, F=1MHz$
Ciss	Input Capacitance	-	6826	-	pF	V _{GS} =0V, V _{DS} =100V, F=1.0MHz
Coss	Output Capacitance	-	356	-		
C _{rss}	Reverse Transfer Capacitance	-	46	-		

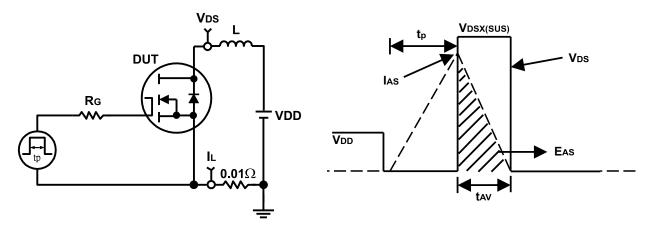
Note [1]: Pulse width is limited by maximum junction temperature.

Note [2]: Pulse test; pulse width \(\le 300\text{us, duty cycle} \(\le 2\)%.

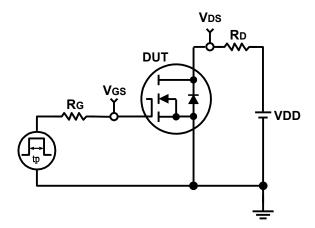
Note [3]: Guaranteed by design, not subject to production testing.

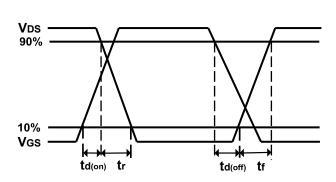


Avalanche Test Circuit and Waveforms



Switching Time Test Circuit and Waveforms

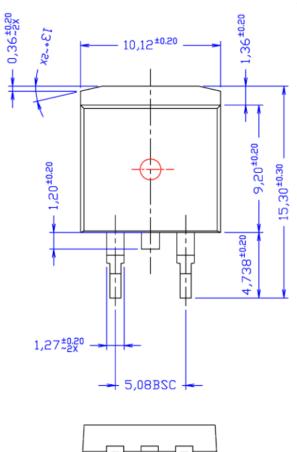


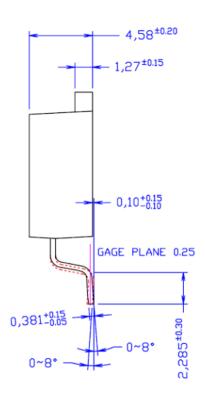


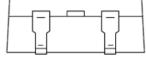


Package Dimensions

TO-263-2









Published by

ARK Microelectronics Co., Ltd.

ADD: D26,UESTC National Science Park No. 1 Shuangxing Avenue, Chengdu, Sichuan. All Rights Reserved.

Disclaimers

ARK Microelectronics Co., Ltd. reserves the right to make change without notice in order to improve reliability, function or design and to discontinue any product or service without notice. Customers should obtain the latest relevant information before orders and should verify that such information is current and complete. All products are sold subject to ARK Microelectronics Co., Ltd's terms and conditions supplied at the time of order acknowledgement.

ARK Microelectronics Co., Ltd. warrants performance of its hardware products to the specifications at the time of sale, Testing, reliability and quality control are used to the extent ARK Microelectronics Co., Ltd deems necessary to support this warrantee. Except where agreed upon by contractual agreement, testing of all parameters of each product is not necessary performed.

ARK Microelectronics Co., Ltd. does not assume any liability arising from the use of any product or circuit designs described herein. Customers are responsible for their products and applications using ARK Microelectronics Co., Ltd's components. To minimize risk, customers must provide adequate design and operating safeguards.

ARK Microelectronics Co., Ltd. does not warrant or convey any license either expressed or implied under its patent rights, nor the rights of others. Reproduction of information in ARK Microelectronics Co., Ltd's data sheets or data books is permissible only if reproduction is without modification or alteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. ARK Microelectronics Co., Ltd is not responsible or liable for such altered documentation.

Resale of ARK Microelectronics Co., Ltd's products with statements different from or beyond the parameters stated by ARK Microelectronics Co., Ltd. for the product or service voids all express or implied warrantees for the associated ARK Microelectronics Co., Ltd's product or service and is unfair and deceptive business practice. ARK Microelectronics Co., Ltd is not responsible or liable for any such statements.

Life Support Policy:

ARK Microelectronics Co., Ltd's products are not authorized for use as critical components in life devices or systems without the expressed written approval of ARK Microelectronics Co., Ltd.

As used herein:

- 1. Life support devices or systems are devices or systems which:
 - a. are intended for surgical implant into the human body,
 - b. support or sustain life,
 - c. whose failure to perform when properly used in accordance with instructions for used provided in the labeling, can be reasonably expected to result in significantinity to the user.
- 2. A critical component is any component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

ARK Microelectronics Co., Ltd.

www.ark-micro.com

Rev. 1.0 Sep. 2020

单击下面可查看定价,库存,交付和生命周期等信息

>>ARK(方舟微)